

**Search Notes**

Application/Control No.

10/760,292

Examiner

Ha T. Nguyen

Applicant(s)/Patent under  
Reexamination

OHASHI ET AL.

Art Unit

2812

**SEARCHED**

Class	Subclass	Date	Examiner
438	691-692	4/12/2005	HN
438	638,687	4/12/2005	HN
134	1-1.3	4/12/2005	HN

**INTERFERENCE SEARCHED**

Class	Subclass	Date	Examiner

**SEARCH NOTES  
(INCLUDING SEARCH STRATEGY)**

	DATE	EXMR
EAST search	4/12/2005	HN